Solid-State Physics

Contributions by R. Dornhaus G. Nimtz W. Richter



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With 152 Figures



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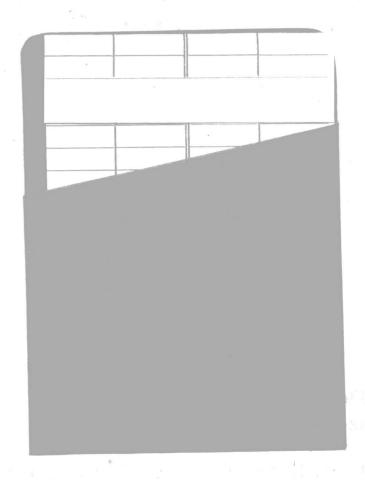
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The Properties and Applications of the Hg_{1-x}Cd_xTe Alloy System

Ralf Dornhaus and Günter Nimtz

1. Introduction

This article is concerned with experimental and theoretical studies on the ${\rm Hg}_{1-{\rm X}}$ ${\rm Cd}_{\rm X}{\rm Te}$ alloy system. We have attempted to present most of the important published data. However, there were frequent cases where an author cited the references as "to be published" or "private communication" and subsequently missed every opportunity actually to publish such work. Thus we were unable to get all the details of the cited data or get information on their background.

Throughout this article we have endeavoured to use SI units consistently (and where convenient appropriate accepted working units such as "eV" and "cm⁻¹"). Although "m⁻³" for particle density etc. may be most unpopular with established workers in the field we count on their indulgence and cooperation in eliminating the confusing mixture of units which is still found in the physical literature.

The earliest investigations on the mixed crystal $\mathrm{Hg}_{1-\mathrm{X}}\mathrm{Cd}_{\mathrm{X}}\mathrm{Te}$ were aimed at the development of infrared detectors /1/, especially for wavelengths around 10 $\mu\mathrm{m}$ controllable by the composition. This is the region of the second atmospheric window and thus of great interest for communication. It covers also the wavelength of the maximum of thermal radiation at room temperature and could be useful for measuring temperature gradients in the environment or in medical applications. Last not least it straddles the wavelengths of CO_2 -layers. Photodetectors made of this mixed crystal have been working now for more than one decade and have proved themselves the most useful ones for the 10 $\mu\mathrm{m}$ region. They had to compete with other narrow band gap materials, above all with the lead salts. However, crystals of $\mathrm{Hg}_{1-\mathrm{X}}\mathrm{Cd}_{\mathrm{X}}\mathrm{Te}$ available nowadays have carrier densities about two orders of magnitude smaller than the lead salts so that their correspondingly larger detectivities more than outweigh the greater difficulty in preparation.

With increasing quality and size of the crystals the HgCdTe alloys attracted the interest of solid state physics. The historical development is similar to that of the classical semiconductors which were used as detectors (with a cat's whisker in the "crystal set" of early radio, and in tens of thousands in the mixer cartridges of wartime microwave radar) long before their basic properties were understood. Today, besides the infrared application, interest centres on phenomena connected with the variation of effective mass and effective g-factor of the conduction band electrons coupled with the variation of the band gap. This shows an approximately linear dependence on the mole fraction x of the components from the positive value for CdTe to the negative one for HgTe. In between there is a composition with zero band gap where according to Kane's theory $\mathtt{m}^* o \mathtt{0}$ and $g^* \rightarrow \infty$ at the conduction band edge. Crystals close to this composition are, therefore, ideal materials for studying various magnetic quantum and also spindependent scattering effects assumed to become more and more pronounced with increasing g-factor which itself represents the spin-orbit interaction. Spin-dependent carrier transport was first observed in magnetic material but is now to be investigated in non-magnetic semiconductors which have a simpler band structure than the magnetic ones. The problem of energy levels of lattice defects in compound semiconductor's such as vacancies and interstitials is also of great interest. As preliminary investigations have shown such defects can generate energy states which interfere with valence band or conduction band states. Various groups are investigating this problem with $Hg_{1-x}Cd_xTe$ alloys, by studying its dependence on the band gap.

In recent years the electronic properties of binary or pseudo-binary alloys have also attracted considerable theoretical interest. The problems of random systems, of which substitutional alloys represent the simplest example, have proved formidable. Many attempts to attack them have been made using a variety of different models. A comparison between experimental and theoretical results may permit a test of different competing theoretical approximations. This may require a reexamination of experimental results, which for lack of a suitable theory have been analysed on the assumption that the alloys were normal crystals. When considering for example the phonon spectrum, alloy scattering or bowing parameters, it has become obvious that the peculiarities of random alloys are important and have to be accounted for in order to obtain a satisfactory theoretical description.

There have been reviews on the ${\rm Hg}_{1-{\rm X}}{\rm Cd}_{\rm X}{\rm Te}$ alloy system which have been published during the last few years by LONG and SCHMIT /2/, HARMAN /3/, and HARMAN and MELNGAILIS /4/. They have the emphasis on the photo detector properties rather than transport properties.

The present article is aiming at a fairly complete review of the current state of the art of this alloy system, useful as a basis for future research. It is in

general restricted to compositions with 0 < x < 1, data of the pure compounds are only given or discussed where those of the mixed crystal are not available.

2. The Crystal

In this chapter the basic physical properties, methods of preparation and imperfections of the $\mathrm{Hg}_{1-\mathrm{X}}\mathrm{Cd}_{\mathrm{X}}\mathrm{Te}$ alloy are presented. Some of these properties, for example the elastic or thermal ones, are only known for the pure compounds. However, these data for the pure compounds do not differ markedly so that they represent a good approximation to the values for intermediate compositions, which are not expected to lie outside those for x = 0 and x = 1.

In the first section the lattice, elastic, thermal, and related properties are given. In the second section the main features of crystal preparation, and in the last section the present knowledge of lattice imperfections are discussed.

2.1 Basic Properties

The $\mathrm{Hg}_{1-\mathrm{X}}\mathrm{Cd}_{\mathrm{X}}\mathrm{Te}$ alloy system is formed by II-VI compounds which are isomorphous with zincblende. In the zincblende structure each Te-ion has four nearest neighbours, which in the alloy may be either Hg or Cd. The five possible basic units around a Te-ion site are shown in Fig. 1a. The Brillouin zone of the zincblende lattice is shown in Fig. 1b with the identification of the main symmetry points and lines used throughout this article. It is usually assumed that in the alloy the anions are distributed randomly with a mean density in accordance with the mole fraction x. On the other hand in mixed crystals a trend for clustering, that is to say non-random distribution, has been often observed. In $\mathrm{Hg}_{1-\mathrm{X}}\mathrm{Cd}_{\mathrm{X}}\mathrm{Te}$ there is so far no definite experimental proof for such an ordering within a distance of some lattice units. The previously observed splitting of the CdTe reststrahl, discussed in section 5.2, may be a pointer to such a clustering.

The lattice parameters of the compounds HgTe and CdTe are very close to each other, but it was observed by various authors /5,6,7/ that their variation with x is not a linear one (see Fig. 2). This is characteristic for many physical properties of the $\mathrm{Hg}_{1-x}\mathrm{Cd}_x\mathrm{Te}$ alloy as will be seen in later chapters. Fig. 2 includes a plot of the measured density versus composition.

In accordance with the zincblende symmetry $(\bar{4}3~\text{m};~T_d)$ the elastic behaviour is determined by three elastic constants. Published data, available on the pure compounds only, describe approximately the elastic properties of the alloy. As seen in Table 1, the values for the two compounds are within the range of experimental

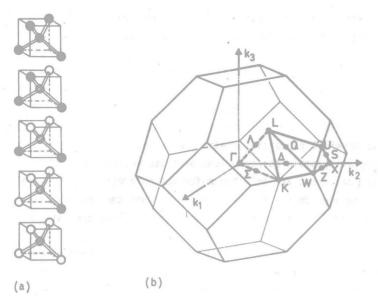


Fig. 1. (a) Basic units of nearest-neighbour ions around a Te-ion site. O Hg, ■ Cd, ■ Te. (b) Brillouin zone of the zincblende structure

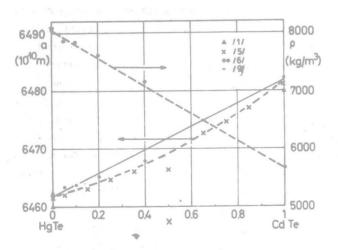


Fig. 2. Lattice parameter a and density ρ for various compositions /1,5,6,9/

error which judging from the scatter of values obtained by different authors seems to be approximately \pm 10 %. Sample preparation was reported by ALPER and SAUNDERS /9/ to have an influence of the same order of magnitude. The data of Table 1 are obtained at various temperatures. In the temperature range between 1.4 K and 300 K the elastic constants of HgTe increase with temperature by approximately 8 % /9/.

Table 1. Elastic stiffness C, deformation potential D, and piezoelectric constant e

Compound	Ref.	Temp.	c ₁₁	c ₁₂	C44	Du	Du'	Dd ^C -Dd ^V	e ₁₄
	u.	[K]	[10]	10 N/m ²]			[eV]		$\left[\text{C/m}^2 \right]$
НдТе	/8/	300	5.08	3.58	2.05				
	/9/	290	5.48	3.81	2.05			1 ₀ = 1	
	/9/	4.2	5.92	4.14	2.19				
CdTe	/12/	300	5.35	3.68	1.99	1.77	4.18	-4.5	
	/16/	77	6.15	4.30	1.96				0.0335

The linear thermal expansion coefficient α of HgTe was investigated by various authors /9-11/. The results show pronounced deviations in the dependence on temperature. For the temperature range between 77 K and 300 K $\alpha \approx 4 \cdot 10^{-6}$ K⁻¹ appears to be a good approximation.

Preliminary results of the variation of the thermal conductivity with composition have been reported by CHASMAR et al. /13/: they observed a minimum at x \approx 0.5. Data on the thermal conductivity and specific heat for $\text{Hg}_{1-x}\text{Cd}_x\text{Te}$, HgTe and CdTe are presented in /14/ and on Debye-Waller factors in /15/.

Crystals with zincblende structure are piezoelectric with one independent component of the piezoelectric tensor. There is no published work on piezoelectric and acoustoelectric effects in the alloy system. The piezoelectric constant ${\rm e}_{14}$ for CdTe /16/ is listed in Table 1. In the alloy the piezoelectric constant which depends on the ionic charge could vary markedly with composition.

2.2 Phase Diagram and Crystal Growth

In view of two surveys /2.3/ published on this topic during the last few years the main problems and methods will only be reported briefly. Most of the problems in crystal growth of the Hg7e-Cd7e pseudobinary system arise from the marked difference between the liquidurand solidus curves. A (T,x)-phase diagram is shown in Fig. 3 /17/. The results of the early investigations on the phase diagram /3.6.18/ have shown a large variation between results for both liquidus and solidus lines obtained by different investigations as indicated by the shaded areas in Fig. 3. Determining the (P,T)-phase diagram and the segregation coefficients SCHMIT and SPEERSCHNEIDER /17/ found that the discrepancy is caused by the dependence of the phase transition on the Hg pressure. This pressure dependence is clearly demonstrated for a composition with x = 0.2 in Fig. 3, the phase transitions are shifted to lower temperatures when the Hg-pressure is decreased form 2.5 bar to 0.36 bar /17/.

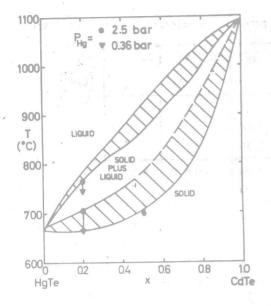


Fig. 3. (T,x) Phase diagram for $Hg_{1-x}Cd_xTe$ /17/. The two pairs of experimental points at x=0.2 demonstrate the influence of mercury pressure on the phase transition

Besides the segregation of CdTe with respect to HgTe there are also problems connected with the segregation of any excess Te in the melt during crystal growth /19/. High quality single crystals of the alloy system have been prepared from ingots either with the three elements or with the two compounds. Growth of crystals by the Bridgman method /2,3,6,19,20/ and by zone melting techniques /21,22/ has been reported. The material as grown, at least in the composition range near x = 0.2, is p-type with $10^{22} - 10^{23}$ holes/m³. In a post-crystal-growth annealing process in a Hg atmosphere the crystal can become n-type with electron densities as low as 10^{20} electrons/m³. The mechanism assumed to cause the type inversion is discussed in the following section.

A large number of investigations have been carried out with the preparation of hetero-structures by solid-state diffusion between samples of bulk CdTe and bulk HgTe /23,24/ and by epitaxial growth /25-31/. The epitaxial growth proceeds via evaporation from a HgTe source and the diffusion into a single crystal CdTe substrate. As a result of the interdiffusion of the two compounds on the CdTe substrate, a film with CdTe is grown. The CdTe content decreases with increasing thickness of the condensed film. Thus the films have a graded band gap structure following the variation of composition with thickness. Such structures have been applied as photovoltaic detectors as discussed in section 6.3.

TUFTE and STELZER /30/ have shown that the growth rate and the surface composition of epitaxial layers can be controlled by the use of excess Hg pressure. Recently this effect was studied more extensively by BAILLY et al. /32/ and by SVOB et al. /33/. The experimental results have shown that with increasing Hg

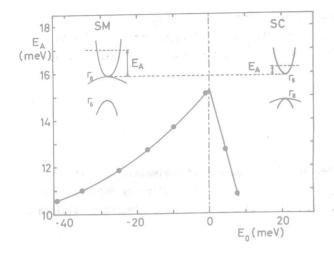
pressure the interdiffusion process between the two compounds is reduced. It is assumed that with increasing Hg pressure the number of vacancies decreases by which the diffusion proceeds /33/. The interdiffusion process was studied also by means of the KIRKENDALL effect /34/.

2.3 Imperfections

Many important physical properties in semiconductors or semimetals such as carrier mobility and carrier density at low temperatures are controlled by imperfections of the crystal. There are three types of imperfection of major interest: dislocations, native point-defects, and foreign atom impurities.

2.3.1 Dislocations and Native Point-Defects

The different types of dislocations in the zincblende structure have been studied by HOLT /35/. One of these, the so-called 60° dislocation was investigated in CdTe. BUCH and AHLOUIST /36/ have shown that this dislocation determines the plastic deformation and acts also as donor or electron trap depending on whether the core of the dislocation is formed by cations or anions in the CdTe compound. So far there is no work available on dislocations in the mixed crystal but there is abundant evidence for native point-defects in the form of vacancies and interstitials. It was soon observed that depending on preparation the samples are n- or p-type. An excess of both types of cations in the crystal yields n-type material, whereas an excess of anion atoms yields p-type material. Thus it is established that free carrier density and carrier type in the extrinsic regime can be controlled by appropriate departures from stoichiometry /2,4,6,17,20,37/. Usually n- or p-type material of $Hg_{1-v}Cd_vTe$ with $x \approx 0.2$ is produced by an annealing process in Hg-rich or Te-rich vapor. It is assumed that three types of defects cause this behaviour, namely Hg and Te vacancies and Hg interstitials. Evidence for Hg vacancies was obtained in semiconducting as well as in semimetallic compositions /38-40/. The Hg vacancy corresponds to an acceptor state, whose energy depends on the mole fraction x, i.e. the band gap as is shown in Fig. 4 /39/. An interesting feature of this acceptor state is that it is resonant with the conduction band for x < 0.16. This acceptor state was studied theoretically by MAUGER and FRIEDEL /39/ and by BASTARD and NOZIERES /41/. ELLIOTT et al. /40/ deduced from thermal freeze-out of carriers and from photoluminescence measurements an acceptor level of about 20 meV above the valence band. This energy value was found in semiconducting p-type material with $0.2 \le x \le 0.5$. It is sensible to assume this acceptor state also to be related to a Hg vacancy. Pressure dependent measurements of galvanomagnetic transport properties with p-type samples of $x \approx 0.15$ yielded two different acceptor



 $\frac{\text{Fig. 4.}}{\text{E}_{A}}$ Acceptor level energy $\frac{\text{E}_{A}}{\text{ensemble}}$ as defined in the insert versus band gap energy /39/

levels /42/. In annealed samples ELLIOTT et al. /42/ could explain the experimental results by an acceptor state 9 meV above the valence band, whereas in as-grown material an acceptor state band of approximately 20 meV above the valence band seems to govern the transport properties.

The infrared emission of hot carriers observed recently /43/ may provide further support to the assumption that a Hg vacancy generates an acceptor state. Comparing the reflectance and the emission spectra which are presented in Figs. 84, 98 it is obvious that in the emission spectrum at the CdTe reststrahl frequency the emission drops to zero but not at the HgTe reststrahl. As described in section 6.4 the p-type layer was obtained by the evaporation of Hg-atoms at the surface of n-type Hg $_8$ Cd $_2$ Te. Thus the HgTe sublattice is strongly disturbed and consequently the HgTe reststrahl affected. It is speculated that a high density of Hg vacancies causes the transparency of the surface layer at the HgTe reststrahl frequency /43/.

Hg-rich material was found to be n-type, which may be caused either by Te vacancies or by Hg-interstitials /2,4,6,17,20,37/. From the analysis of various transport effects with n-type Hg 8Cd 2Te DORNHAUS et al. /44/ concluded that the conduction band electrons might be generated by Te vacancies rather than by Hg-interstitials. In the same samples a resonant electronic state was observed in Shubnikov-de Haas experiments and also in the far infrared transmission /45/. The experimental data can be described by an electronic state which is resonant with the conduction band as sketched in the insert of Fig. 5. The energy level of this state is approximately 8 meV above the conduction band at 4.2 K. The absorption coefficient for the transition from conduction band to the resonant level was calculated by analogy with the deuteron photoionization cross section and is compared with experimental data evaluated from transmission measurements in Fig. 5. There are some